

**Search Notes**

Application/Control No.

10/674,552

Examiner

David Y. Chung

Applicant(s)/Patent under  
Reexamination

CHAE ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	155	1/22/2006	DC
349	156	1/22/2006	DC
349	123	1/22/2006	DC
349	124	1/22/2006	DC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same	same	1/22/2006	DC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search report	1/22/2006	DC